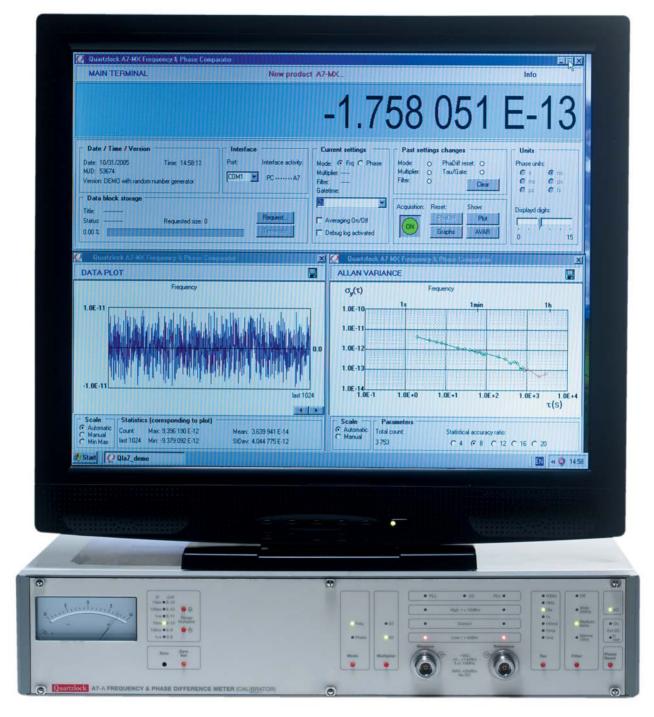
Frequency & Phase Measurement System



New for 2007

- Data stored in A7-MX
- RS232 connect to PC
- 32000 data point storage
- Crash proof with 24Vdc Battery Back Up
- On screen plot in real time
- Large digital display of $\Delta \emptyset$ or Δf
- Measurement error fully specified

Features

- Very high resolution: 50fs single shot
- Very low noise: 1s <5x10⁻¹⁴
- Ultra fast measurement time
- Sample rate: 1000 readings/second
- A7-A (Analogue): simple to use E-13 resolution
- A7-M (Metrology): best available E-16 resolution
- Selectable filters, resolutions & tau's
- Phase/frequency meter extremely useful

Applications from Metrology to Production Test

- Stability analysis
- Phase noise analysis
- Atomic frequency standard calibration
- Active & passive component stability measurement
- ADEV, Modified ADEV, TVAR, MTIE etc
- Temperature & Phase testing

Benefits

- Unskilled operation
- Unequaled performance
- External PC enables low cost 2-3 year upgrades
- Precision product characterisation
- "National Measurement" with H-Maser/C's

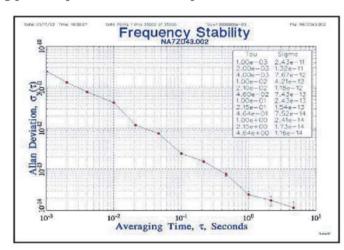


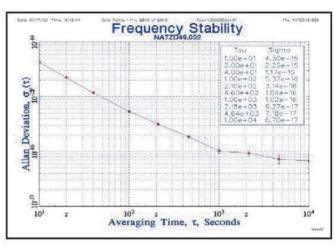
Frequency & Phase Measurement System A 7 - M

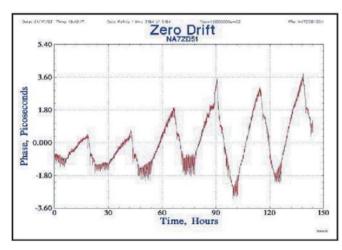


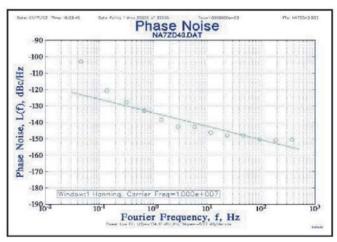
SPECIFICATIONS					
Inputs a) Reference b) Measurement (3 measurement inputs = A7-MY) c) Input levels: d) Max Freq difference (Filter off):	5 or 10MHz sine wave $\pm 5 \times 10^{-5}$ 5 or 10MHz sine wave $\pm 5 \times 10^{-5}$ +0dBm to +13dBm into 50Ω Low resolution $\pm 1 \times 10^{-5}$ High resolution $\pm 1 \times 10^{-7}$		±5x10 ⁻⁵ ±1x10 ⁻⁵	50 PPM 50 PPM 10 PPM 10 PPB	50x10 ⁻⁶ 50x10 ⁻⁶ 10x10 ⁻⁸ 10x10 ⁻⁸
Outputs a) Counter A channel b) Counter B channel c) Counter external reference	100kHz square wave CMOS/TTL (frequency mode) 10us pulse CMOS/TTL (phase difference mode) 10us pulse CMOS/TTL (phase difference mode) 10MHz CMOS/TTL				
Filter Nominal 3dB Bandwidths	Selectable bandwidth IF filter reduces measurement noise 200Hz, 60Hz, 10Hz				
Fractional frequency multiplication Selectable	High resolution 10 ⁵ Low resolution 10 ³				
Measurement resolution Frequency difference mode RMS resolution (filter 200Hz)	A7-MX Using internal phase/freq. meter (TIC) and Windows software	A7-A + Ext TIC Using external frequency/time interval counter with 1ns or better time interval resolution		*Note option 2 delete	
High resolution Low resolution	1x10 ⁻¹³ /gate time 1x10 ⁻¹² /gate time	1x 10 ⁻¹³ /gate time 1x10 ⁻¹² /gate time			
Meter Full scale ranges (decade steps) Time constant (linked to range) Time constant multiplier Displayed Noise Zero drift	±1x10 ⁻⁷ to ±1x10 ⁻¹² 20ms to 10 Sec x 1, x3, x10 <2x10 ⁻¹³ peak <2x10 ⁻¹³ /hour	±1x10 ⁻⁷ to ±1x10 ⁻¹² 20ms to 10 Sec x 1, x3, x10 <2x10 ⁻¹³ peak <2x10 ⁻¹³ /hour		±1x10 ⁻⁷ to ±1x10 ⁻¹² 20ms to 10 Sec x 1, x3, x10 <2x10 ⁻¹³ peak <2x10 ⁻¹³ /hour	
Phase difference mode (High resolution, Filter 200Hz)		10ps1µs/div			
RMS resolution (single measurement)	50fs*1	50fs*1			
Meter Full scale ranges (decade steps) Displayed noise Zero drift	±10us to ±100ps <1ps peak <1ps/hour	±10us to ±100ps <1ps peak <1ps/hour		±10us to ±100ps <1ps peak <1ps/hour	
Short-term stability Tau 1ms 10ms 100ms 1s 10s 100s 1000s 10000s	Allan variance <5x10 ⁻¹¹ <5x10 ⁻¹² <5x10 ⁻¹³ <5x10 ⁻¹⁴ <1x10 ⁻¹⁴ <2x10 ⁻¹⁵ <5x10 ⁻¹⁶ <1x10 ⁻¹⁶	<5x10 ⁻¹¹ <5x10 ⁻¹² <5x10 ⁻¹³ <5x10 ⁻¹⁴ <1x10 ⁻¹⁴ <2x10 ⁻¹⁵ <5x10 ⁻¹⁶ <1x10 ⁻¹⁶		Δf/f 1×10 ⁻⁸ 1×10 ⁻⁹ 1×10 ⁻¹⁰ 1×10 ⁻¹¹ 1×10 ⁻¹² 1×10 ⁻¹³ Analogue meter reso selected from 6 rang	Phase 1µs 100ns 10ns 1ns 1ns 100ps 10ps ution manually
Sampling interval	1ms to 2000s 1, 2, 5 Steps	1ms to 1000s Decade Steps			
Drift Hour Day Temperature	<1ps typical <5ps typical <2ps/°C	<1ps typical at constant ambient temperature <5ps typical at constant ambient temperature <2ps/°C			
Measurement Error Input referred self generated spurii 10³ multiplication 10⁵ multiplication Corresponding peak phase modulation 10⁵ multiplication 10⁵ multiplication Allen Variance Error (due to each spur)*³ 10³ multiplication 10⁵ multiplication	<-90dBc <-100dBc <1ps <0.3ps 10 ⁻¹² divided by average 3x10 ⁻¹³ divided by average			te: phase modulation spu tiples of the input freque	
MECHANICAL	2U 19" rack unit WxHxD(max) 450(483)x88(96)x345(370) <9kg				
POWER SUPPLY	120/ 240V AC line 50W max 24V DC battery backup with automatic switching. Current consumption 1Amp max. With option 1 add 1Amp 1 Measured as the standard deviation of 1024 phase difference measurements/1.024s 2 Measured as the standard deviation of 1000 phase difference measurements/1s 3 Phase modulation spurii will be present at multiples of the input frequency difference				

Typical performance plots





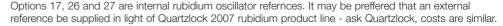




ORDERING INFORMATION - A7-MX OPTIONS



- Distribution Card 1 Input 4 Outputs (for reference outputs)
- 2 Delete internal phasemeter (time interval counter) and software
- 17 Add A10-LPRO High Performance Rubidium Oscillator (STD Version)
- Add Additional 1 to 5 Years Warranty (18.1 = 1 Year ... 18.5 = 5 years) 18
- 26 Change to LPRO HS High Stability Rubidium Oscillator from LPRO
- 27 Change to LPRO LN Low Phase Noise Rubidium Oscillator from LPRO -160dBc/Hz
- 32 Stable 32 Analysis Software also enables phase noise calc.
- 36 Training



Non standard options - ask Quartzlock

- Automatic Close-in Phase Noise Calculation display
 Wide Frequency range 4kHz....65MHz @ reduced or full performance (3rd input)
- User specified input range up to microwave frequencies
- Isolated inputs ATE version (remote filter select) Cable set
- Lower related noise (5 & 10MHz input) Zero drift input splitter 100MHz input



Option 2 A7-A as A7-MX but less Internal Time Interval Counter, Computer Control and Quartzlock Analysis Software



uartzlock Frequency & Phase Measurement System A 7

Technical Description

What it does

The A7 revision 6 frequency/phase difference comparator is an improved version of the previous model A7 Quartzlock product for measuring a wide range of frequency standards, isolation amplifiers, frequency multipliers and dividers, and passive devices such as cables. The instrument is self contained with an internal phasemeter and needs no external counter. A PC running most operating systems with one RS232 port provides a sophisticated user interface with immediate calculation and graphing of Allan variance. A digital display of phase or fractional frequency offset is provided. Tau values from 1ms to 2000 seconds may be used. A unique RS232 interface protocol has been designed which prevents Windows from losing data. The phasemeter has a 32k buffer which provides complete protection to the data if the computer fails during a measurement run. Data blocks with up to 32k readings may be stored to disk for analysis with an external program such as Stable 32.

Analogue or digital display

The instrument includes a moving coil meter for rapid, unambiguous display of fractional frequency difference or relative phase difference between two sources. Outputs are also provided for an external counter to connect to existing logging equipment if required. The instrument combines the production oriented capability of rapidly adjusting a source to within a certain tolerance using the panel meter, along with the metrology capability of a full time domain analysis of a source or passive component using data acquisition from the internal phasemeter or external counter.

Noise & drift - very low

The A7 comparator has state of the art noise floor and drift characteristics. Its technique of frequency multiplication followed by down conversion provides lower noise floors than the simpler dual mix downconvert system. The very low drift is achieved by providing identical multiplier/mixing chains for the reference and measurement channels. When the multiplied signals are finally mixed together (subtracted), any drift in the multiplier chains is cancelled.

The automatic battery backup facility fitted as standard enables very long measurement runs to be undertaken without concerns over line power failures. An external 24V battery will power the instrument for at least 24 hours (without option 3)

A Rubidium frequency standard may be fitted internally or externally (Option) along with a 4 output distribution amplifier with very low phase noise (Option).

How it works

Measurements are made in the time domain and consist of time difference measurements between a reference source and a measurement source. Measurements may be made on passive devices such as amplifiers by splitting a source output and comparing the time delay through the item under test with the direct path. In this way the time or phase stability of the amplifier may be measured. Unlike a general purpose time interval meter the inputs must be substantially sine wave and at either 5MHz or 10MHz. The resolution is much better than even the fastest counters, being around 50fs for a single measurement.

The A7 is a completely new design using phase locked multipliers as opposed to the harmonic multipliers used in previous Quartzlock phase/frequency comparators. Several new features have been added. The frequency input range is much wider, enabling measurements on VCXOs and OCXOs. Two resolutions are provided, with multiplication factors of 10³ and 10⁵. This optimises measurement on very stable sources such as Rubidium and Caesium oscillators and Hydrogen Masers, as well as lower stability sources. A variable band width IF filter has been added. This essentially sets the measuring bandwidth and allows sources with considerable phase noise to be filtered.



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2007 - new features cont. -

This has particular advantages in frequency mode where the apparent jitter of a real time frequency readout can be reduced. A Rubidium frequency standard can be adjusted using 100ms sampling time to an accuracy of 1x10¹². The phasemeter may be set to sample at the maximum rate of 1ms, with averaging to generate samples at the requested lower sampling rate. This digital averaging provides lower noise with some sources.

Input spec

The comparator will operate at either 5MHz or 10MHz with automatic switching. The inputs are 50ohm impedance, and a level of between 0dBm and 13dBm is required at both inputs. The absolute accuracy of both reference and measurement inputs should be less than ±50 in 10°. The maximum frequency difference should be less than ±10 in 10⁶ in low resolution mode and less than ±100 in 109 in high resolution mode. The inputs are provided with level indicators.

FREQUENCY - Modes, ranges and resolution -

The comparator has two modes of operation, frequency measurement mode and phase difference mode. In frequency mode the moving coil meter indicates fractional frequency difference and the phasemeter is configured as a frequency counter. Meter full scale ranges are selectable from the front panel in the range $\pm 10^{-7}$ to $\pm 10^{-12}$. The internal phasemeter is configured as a frequency counter with gate times selected on the PC virtual panel as usual for a frequency measurement. The digital display shows fractional frequency with selectable number of digits displayed. The RMS resolution is typically better than 5 parts in 10¹⁴ for a 1 second gate. The Allen variance is calculated automatically and continuously as the samples are accumulated, and the graph is updated.

In phase mode, the moving coil meter is configured to read phase difference between the reference and the measurement inputs. The full scale range is selectable between ±10us to ±100ps. An extended range phase detector is used so phase roll over will be between +10 and 0 on the meter if the frequency is increasing, and between -10 and 0 on the meter if the frequency is decreasing. The meter shows relative phase difference between the reference and measurement inputs. Because of the multiplication process in the comparator, the absolute phase difference is not available. A phase reset key is provided that zeros the indicated phase to within ±100ps.

The internal phasemeter is configured as a time interval meter and measures the time difference between the measurement and reference channels. The sampling rate is set on the PC virtual panel. The phase may be reset to zero on the virtual panel. Allen variance is calculated continuously from the phase data. The single shot time resolution (measured as the standard deviation of 1024 readings accumulated over 1.024 seconds) is less than 50fs.

In both frequency and phase mode blocks of data may be accumulated and stored to disk. The block size may be up to 32k readings. The data is stored internally in the phase meter so that a failure of the computer or slow operation of the RS232 interface cannot lose any data. The computer may be used for other applications with the A7 application minimised without any concerns.

A sophisticated software package is available for analysis of data (Option). This is Stable 32 supplied by Hamilton Technical Services. It supports every possible type of time domain stability analysis, as well as conversion to the frequency domain for close in phase noise analysis.

hat you have as standard + options

A7-MX supplied is supplied with internal TIC providing RS232 for connection to a PC, Options:- Stable32 Frequency Analysis Software, High Performance Rubidium Module and 4 Channel RF Distribution Card.

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